



RADIO TEST REPORT

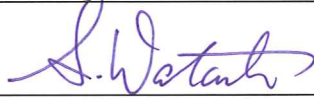
Test Report No. : 11398804H

Applicant : DENSO CORPORATION
Type of Equipment : Electronic Key
Model No. : 14FBH
Test regulation : FCC Part 15 Subpart C: 2016
FCC ID : HYQ14FBH
Test Result : Complied


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2. The results in this report apply only to the sample tested.
3. This sample tested is in compliance with above regulation.
4. The test results in this report are traceable to the national or international standards.
5. This test report must not be used by the customer to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the Federal Government.
6. This test report covers Radio technical requirements. It does not cover administrative issues such as Manual or non-Radio test related Requirements. (if applicable)

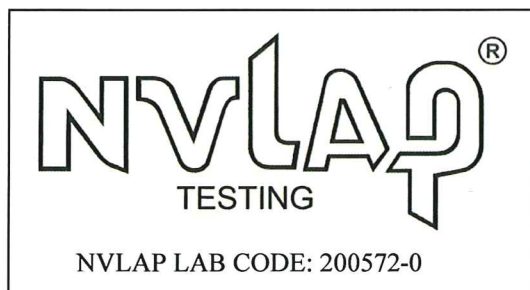
Date of test: August 17 and 19, 2016

Representative test engineer:


Shinya Watanabe
Engineer
Consumer Technology Division

Approved by:


Motoya Imura
Engineer
Consumer Technology Division



This laboratory is accredited by the NVLAP LAB CODE 200572-0, U.S.A. The tests reported herein have been performed in accordance with its terms of accreditation.
*As for the range of Accreditation in NVLAP, you may refer to the WEB address,
http://japan.ul.com/resources/emc_accredited/

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Ise EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8999

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13-EM-F0429

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SECTION 1: Customer information

Company Name : DENSO CORPORATION
Address : 1-1 Showa-cho, Kariya-shi, Aichi-ken, 448-8661 Japan
Telephone Number : +81-566-61-5242
Facsimile Number : +81-566-25-4837
Contact Person : MASAYUKI YAMAMOTO

SECTION 2: Equipment under test (E.U.T.)

2.1 Identification of E.U.T.

Type of Equipment : Electronic Key
Model No. : 14FBH
Serial No. : Refer to Clause 4.2
Rating : DC 3.0 V
Receipt Date of Sample : August 17, 2016
Country of Mass-production : Japan
Condition of EUT : Engineering prototype
(Not for Sale: This sample is equivalent to mass-produced items.)
Modification of EUT : No Modification by the test lab

2.2 Product Description

Model No: 14FBH (referred to as the EUT in this report) is the Electronic Key.

Radio Type : Transceiver
Frequency of Operation : 314.35 MHz / 312.10 MHz*
Clock frequency(ies) in the system : 33.6 MHz Crystal (RF)
8 MHz (IC Clock)
Modulation : FSK (F1D)
Power Supply (radio part input) : DC 3.0 V
Type of Battery : One lithium battery
Antenna type : Built-in type (Fixed)
Receiving frequency of Operation : 134.2 kHz *1)

* These two different frequencies are not emitted simultaneously.

*1) The test of receiver part was performed separately from this test report, and the conformability is confirmed.

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SECTION 3: Test specification, procedures & results

3.1 Test Specification

Test Specification : FCC Part 15 Subpart C
FCC part 15 final revised on April 6, 2016.

Title : FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators
Section 15.231 Periodic operation in the band 40.66 - 40.70MHz
and above 70MHz

3.2 Procedures and results

Item	Test Procedure	Specification	Worst margin	Results	Remarks
Conducted emission	FCC: ANSI C63.10:2013 6 Standard test methods	FCC: Section 15.207	N/A	N/A*1)	-
	IC: RSS-Gen 8.8	IC: RSS-Gen 8.8			
Automatically Deactivate	FCC: ANSI C63.10:2013 6 Standard test methods	FCC: Section 15.231(a)(1)	N/A	Complied	Radiated
	IC: -	IC: RSS-210 A1.1.1			
Electric Field Strength of Fundamental Emission	FCC: ANSI C63.10:2013 6 Standard test methods	FCC: Section 15.231(b)	6.6 dB Horizontal, PK (PK with Duty factor) (T.x 314.35 MHz)	Complied	Radiated
	IC: RSS-Gen 6.12	IC: RSS-210 A1.1.2			
Electric Field Strength of Spurious Emission	FCC: ANSI C63.10:2013 6 Standard test methods	FCC: Section 15.205 Section 15.209 Section 15.231(b)	10.4 dB 2808.900 MHz Horizontal/Vertical PK (PK with Duty factor) (Tx 312.10 MHz)	Complied	Radiated
	IC: RSS-Gen 6.13	IC: RSS-210 A1.1.2, 2.5.1 RSS-Gen 8.9			
-20dB Bandwidth	FCC: ANSI C63.10:2013 6 Standard test methods	FCC: Section 15.231(c)	N/A	Complied	Radiated
	IC: -	IC: Reference data			

Note: UL Japan, Inc.'s EMI Work Procedures No. 13-EM-W0420 and 13-EM-W0422.

*1) The test is not applicable since the EUT does not have AC Mains.

FCC Part 15.31 (e)

This test was performed with the New Battery (DC 3.0 V) during the tests. Therefore, the EUT complies with the requirement.

FCC Part 15.203 Antenna requirement

It is impossible for end users to replace the antenna, because the antenna is mounted inside of the EUT. Therefore, the equipment complies with the antenna requirement of Section 15.203.

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4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

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3.3 Addition to standard

Item	Test Procedure	Specification	Worst margin	Results	Remarks
99 % Occupied Bandwidth	IC: RSS-Gen 6.6	IC: RSS-210 A1.1.3	N/A	Complied	Radiated

Other than above, no addition, exclusion nor deviation has been made from the standard.

3.4 Uncertainty

EMI

The following uncertainties have been calculated to provide a confidence level of 95 % using a coverage factor $k = 2$.

Polarity	Radiated emission (Below 1GHz)			
	(3 m*)(+/-)		(10 m*)(+/-)	
	30 – 200 MHz	200 – 1000MHz	30 – 200 MHz	200 – 1000MHz
Horizontal	5.0 dB	5.3 dB	5.0 dB	5.0 dB
Vertical	4.7 dB	5.9 dB	5.0 dB	5.1 dB

Radiated emission (Above 1GHz)				
(3 m*)(+/-)		(1 m*)(+/-)		(10 m*)(+/-)
1 – 6GHz	6 – 18GHz	10 – 26.5 GHz	26.5 – 40GHz	1 -18 GHz
5.2 dB	5.4 dB	5.5 dB	5.5 dB	5.4 dB

* Measurement distance

Radiated emission test (3 m)

The data listed in this test report has enough margin, more than the site margin.

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Facsimile : +81 596 24 8124

3.5 Test Location

UL Japan, Inc. Ise EMC Lab. *NVLAP Lab. code: 200572-0
4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN
Telephone : +81 596 24 8999 Facsimile : +81 596 24 8124

	IC Registration Number	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms
No.1 semi-anechoic chamber	2973C-1	19.2 x 11.2 x 7.7m	7.0 x 6.0m	No.1 Power source room
No.2 semi-anechoic chamber	2973C-2	7.5 x 5.8 x 5.2m	4.0 x 4.0m	-
No.3 semi-anechoic chamber	2973C-3	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.3 Preparation room
No.3 shielded room	-	4.0 x 6.0 x 2.7m	N/A	-
No.4 semi-anechoic chamber	2973C-4	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.4 Preparation room
No.4 shielded room	-	4.0 x 6.0 x 2.7m	N/A	-
No.5 semi-anechoic chamber	-	6.0 x 6.0 x 3.9m	6.0 x 6.0m	-
No.6 shielded room	-	4.0 x 4.5 x 2.7m	4.0 x 4.5 m	-
No.6 measurement room	-	4.75 x 5.4 x 3.0m	4.75 x 4.15 m	-
No.7 shielded room	-	4.7 x 7.5 x 2.7m	4.7 x 7.5m	-
No.8 measurement room	-	3.1 x 5.0 x 2.7m	N/A	-
No.9 measurement room	-	8.0 x 4.6 x 2.8m	2.4 x 2.4m	-
No.11 measurement room	-	6.2 x 4.7 x 3.0m	4.8 x 4.6m	-

* Size of vertical conducting plane (for Conducted Emission test): 2.0 x 2.0m for No.1, No.2, No.3, and No.4 semi-anechoic chambers and No.3 and No.4 shielded rooms.

3.6 Test data, Test instruments, and Test set up.

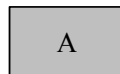
Refer to APPENDIX.

SECTION 4: Operation of E.U.T. during testing

4.1 Operating Modes

Test Item	Mode
Automatically Deactivate	Normal use mode, 314.35 MHz Normal use mode, 312.10 MHz
Electric Field Strength of Fundamental Emission Electric Field Strength of Spurious Emission -20dB & 99% Occupied Bandwidth	Transmitting mode (Tx), 312.10 MHz *1) Transmitting mode (Tx), 314.35 MHz *1)
<p>* The system was configured in typical fashion (as a customer would normally use it) for testing. *1) The software of this mode is the same as one of normal product, except that EUT continues to transmit when transmitter button is being pressed (For Normal use mode, the EUT transmits when it receives 134.2 kHz radio signal and transmitter button is being pressed.) End users cannot change the settings of the output power of the product.</p>	

4.2 Configuration and peripherals



* Setup was taken into consideration and test data was taken under worse case conditions.

Description of EUT

No.	Item	Model number	Serial number	Manufacturer	Remarks
A	Electronic Key	14FBH	001 *1) 002 *2)	DENSO CORPORATION	EUT

*1) Used for Transmitting mode.

*2) Used for Normal use mode.

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Ise EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8999

Facsimile : +81 596 24 8124

SECTION 5: Radiated emission (Electric Field Strength of Fundamental and Spurious Emission)

Test Procedure and conditions

[For below 1GHz]

EUT was placed on a urethane platform of nominal size, 0.5 m by 1.0 m, raised 0.8 m above the conducting ground plane. The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with a ground plane.

[For above 1GHz]

EUT was placed on a urethane platform of nominal size, 0.5 m by 0.5 m, raised 1.5 m above the conducting ground plane. The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with absorbent materials lined on a ground plane.

Test was made with the antenna positioned in both the horizontal and vertical planes of polarization. The measurement antenna was varied in height above the conducting ground plane to obtain the maximum signal strength. Photographs of the set up are shown in Appendix 3.

[Transmitting mode]

(Below 30 MHz)

The noise level was checked by moving a search-coil (Loop Antenna) close to the EUT.

(Above 30 MHz)

The Radiated Electric Field Strength has been measured on Semi anechoic chamber with a ground plane and at a distance of 3 m.

The measuring antenna height was varied between 1 and 4 m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field strength.

The measurements were performed for both vertical and horizontal antenna polarization.

The radiated emission measurements were made with the following detector function of the test receiver / spectrum analyzer.

Test Antennas are used as below;

Frequency	Below 30 MHz	30 MHz to 200 MHz	200 MHz to 1 GHz	Above 1 GHz
Antenna Type	Loop	Biconical	Logperiodic	Horn

	From 9 kHz to 90 kHz and From 110 kHz to 150 kHz	From 90 kHz to 110 kHz	From 150 kHz to 490 kHz	From 490 kHz to 30 MHz	From 30 MHz to 1 GHz	Above 1 GHz
Detector Type	Peak	Peak	Peak	Peak	Peak and Peak with Duty factor	Peak and Peak with Duty factor
IF Bandwidth	200 Hz	200 Hz	9.1 kHz	9.1 kHz	120 kHz	PK: S/A: RBW 1 MHz, VBW: 3 MHz

- The carrier level (or, noise levels) was (or were) measured at each position of all three axes X, Y and Z, and the position that has the maximum noise was determined.

Noise levels of all the frequencies were measured at the position.

This EUT has two modes which mechanical key is inserted or not. The worst case was confirmed with and without mechanical key, as a result, the test with mechanical key was the worst case. Therefore the test with mechanical key was performed only.

*The result is rounded off to the second decimal place, so some differences might be observed.

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4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8999

Facsimile : +81 596 24 8124

Measurement range : 9 kHz - 3.2 GHz
Test data : APPENDIX
Test result : Pass

SECTION 6: Automatically deactivate

Test Procedure

The measurement was performed with Electric field strength using a spectrum analyzer.

Test data : APPENDIX
Test result : Pass

SECTION 7: -20 dB and 99 % Occupied Bandwidth

Test Procedure

The test was measured with a spectrum analyzer using a test fixture.

Test	Span	RBW	VBW	Sweep	Detector	Trace	Instrument used
20 dB Bandwidth	150 kHz	1.5 kHz	5.1 kHz	Auto	Peak	Max Hold	Spectrum Analyzer
99 % Occupied Bandwidth	Enough width to display emission skirts	1 to 5 % of OBW	Three times of RBW	Auto	Peak	Max Hold	Spectrum Analyzer

Peak hold was applied as Worst-case measurement.

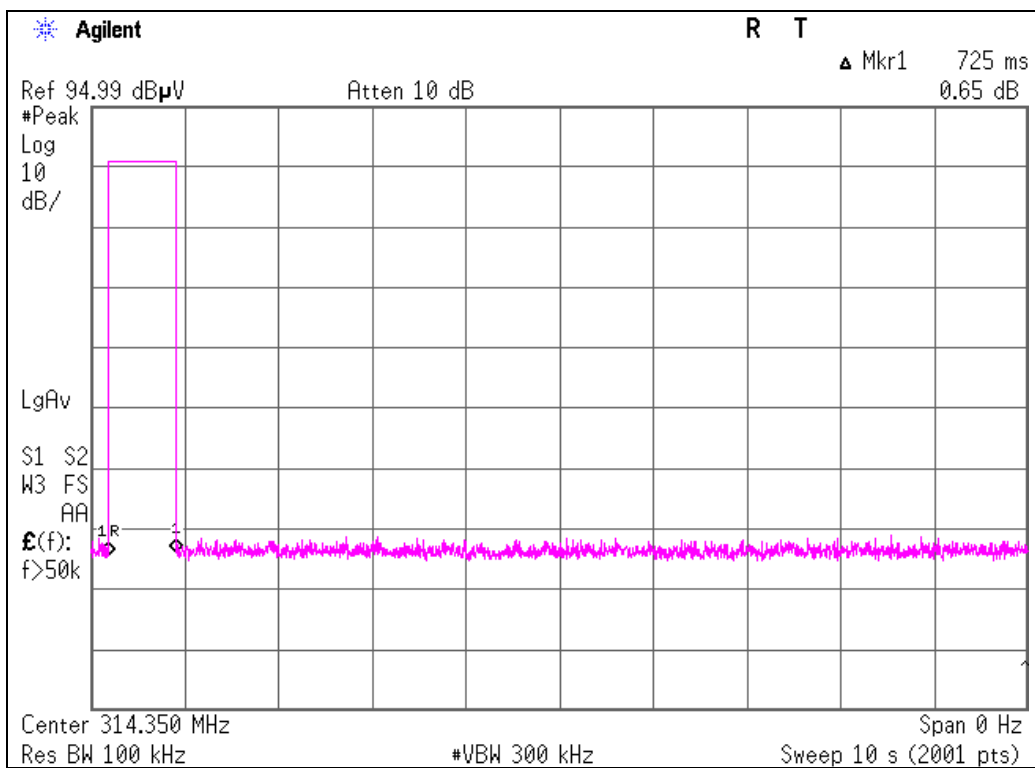
Test data : APPENDIX
Test result : Pass

APPENDIX 1: Test data

**Automatically deactivate
314.35 MHz**

Test place	Ise EMC Lab. No.4Semi Anechoic Chamber
Report No.	11398804H
Date	08/17/2016
Temperature/ Humidity	24 deg. C / 54% RH
Engineer	Shinya Watanabe
Mode	Normal use mode 314.35 MHz

Time of Transmitting [sec]	Limit [sec]	Result
0.725	5.00	Pass



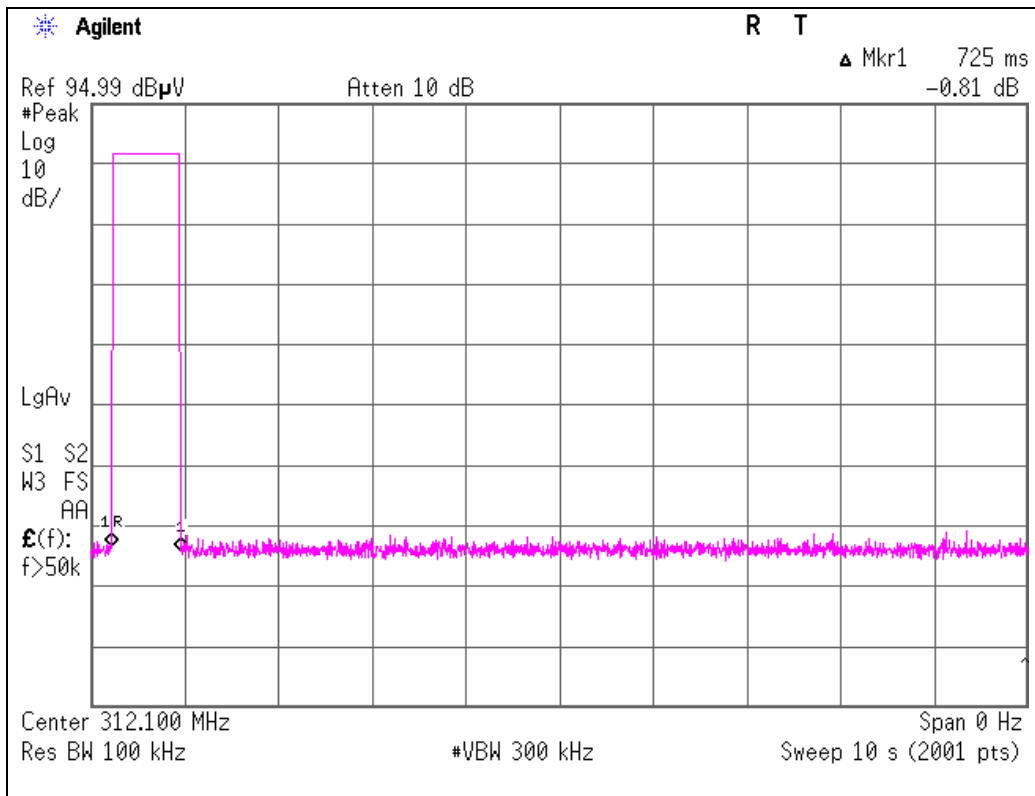
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 Facsimile : +81 596 24 8124

Automatically deactivate
312.10 MHz

Test place	Ise EMC Lab. No.4 Semi Anechoic Chamber
Report No.	11398804H
Date	08/17/2016
Temperature/ Humidity	24 deg. C / 54% RH
Engineer	Shinya Waytanabe
Mode	Normal use mode, 312.10MHz

Time of Transmitting [sec]	Limit [sec]	Result
0.725	5.00	Pass



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Telephone : +81 596 24 8999

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Radiated Emission (Electric Field Strength of Fundamental and Spurious Emission)
312.10 MHz

Test place : Ise EMC Lab.
Semi Anechoic Chamber : No.4
Report No. : 11398804H
Date : 08/17/2016
Temperature/ Humidity : 21 deg. C / 56 % RH
Engineer : Shinya Watanabe
Mode : Transmitting mode (Tx), 312.10 MHz

08/19/2016
23 deg. C / 53 % RH
Shinichi Miyazono
(Above 1 GHz)

PK

Frequency [MHz]	Detector	Reading [dBuV]		Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]		Limit [dBuV/m]	Margin [dB]		Remark Inside or Outside of Restricted Bands
		Hor	Ver					Hor	Ver		Hor	Ver	
312.100	PK	76.6	72.2	13.7	9.9	31.9	-	68.3	63.9	95.4	27.1	31.5	Carrier
624.200	PK	31.0	35.1	19.2	11.7	32.2	-	29.7	33.8	75.4	45.7	41.6	Outside
936.300	PK	27.8	33.1	22.0	13.2	31.0	-	32.0	37.3	75.4	43.4	38.1	Outside
1248.400	PK	43.6	43.4	24.9	5.4	34.2	-	39.7	39.5	75.4	35.7	35.9	Outside
1560.500	PK	42.1	42.1	25.6	5.6	33.3	-	40.0	40.0	73.9	33.9	33.9	Inside
1872.600	PK	42.2	41.8	27.0	5.8	32.6	-	42.4	42.0	75.4	33.0	33.4	Outside
2184.700	PK	41.3	41.3	27.7	6.0	32.2	-	42.8	42.8	75.4	32.6	32.6	Outside
2496.800	PK	40.6	40.6	28.1	6.2	32.1	-	42.8	42.8	73.9	31.1	31.1	Inside
2808.900	PK	41.0	41.0	28.2	6.3	32.0	-	43.5	43.5	73.9	30.4	30.4	Inside
3121.000	PK	41.5	40.8	28.4	6.5	31.9	-	44.5	43.8	75.4	30.9	31.6	Outside

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier)

PK with Duty factor

Frequency [MHz]	Detector	Reading [dBuV]		Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]		Limit [dBuV/m]	Margin [dB]		Remark
		Hor	Ver					Hor	Ver		Hor	Ver	
312.100	PK	76.6	72.2	13.7	9.9	31.9	0.0	68.3	63.9	75.4	7.1	11.5	Carrier
624.200	PK	31.0	35.1	19.2	11.7	32.2	0.0	29.7	33.8	55.4	25.7	21.6	Outside
936.300	PK	27.8	33.1	22.0	13.2	31.0	0.0	32.0	37.3	55.4	23.4	18.1	Outside
1248.400	PK	43.6	43.4	24.9	5.4	34.2	0.0	39.7	39.5	55.4	15.7	15.9	Outside
1560.500	PK	42.1	42.1	25.6	5.6	33.3	0.0	40.0	40.0	53.9	13.9	13.9	Inside
1872.600	PK	42.2	41.8	27.0	5.8	32.6	0.0	42.4	42.0	55.4	13.0	13.4	Outside
2184.700	PK	41.3	41.3	27.7	6.0	32.2	0.0	42.8	42.8	55.4	12.6	12.6	Outside
2496.800	PK	40.6	40.6	28.1	6.2	32.1	0.0	42.8	42.8	53.9	11.1	11.1	Inside
2808.900	PK	41.0	41.0	28.2	6.3	32.0	0.0	43.5	43.5	53.9	10.4	10.4	Inside
3121.000	PK	41.5	40.8	28.4	6.5	31.9	0.0	44.5	43.8	55.4	10.9	11.6	Outside

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier) + Duty factor

For above 1 GHz: Distance Factor: 20 x log(4.5 m / 3.0m) = 3.52 dB

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20dB).

Since the peak emission result satisfied the average limit, duty factor was omitted.

Although Duty of this product was 100% or less, the result of AV (PK with Duty factor) was calculated by applying Duty 100% as worst.

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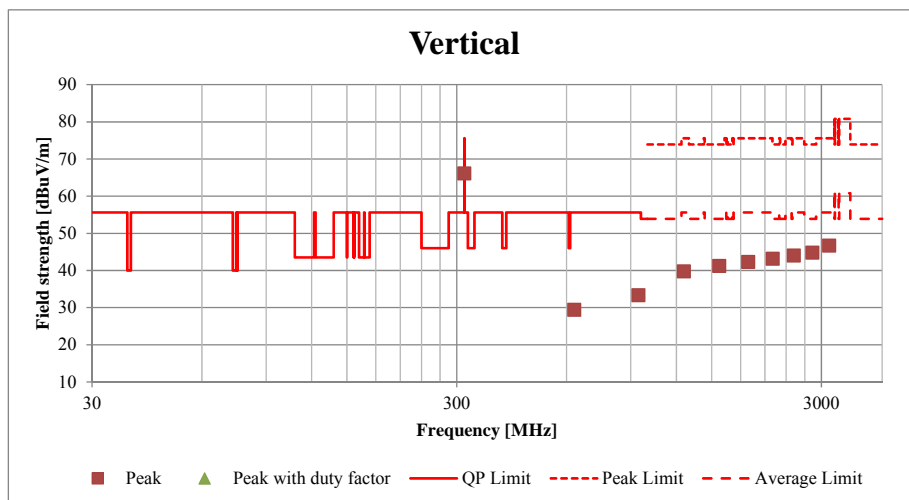
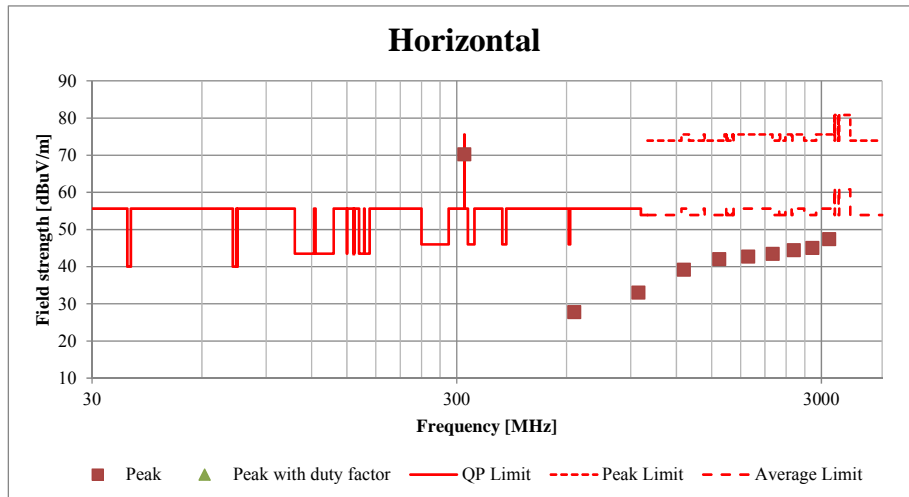
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Telephone : +81 596 24 8999

Facsimile : +81 596 24 8124

Radiated Spurious Emission
(Plot data, Worst case)

Test place	Ise EMC Lab.	
Semi Anechoic Chamber	No.4	
Report No.	11398804H	
Date	08/17/2016	08/19/2016
Temperature/ Humidity	21 deg. C / 56% RH	23 deg. C / 53 % RH
Engineer	Shinya Watanabe (Below 1 GHz)	Shinichi Miyazono (Above 1 GHz)
Mode	Transmitting mode (Tx), 314.35 MHz	



*These plots data contains sufficient number to show the trend of characteristic features for EUT.

-20dB and 99% Occupied Bandwidth
314.35 MHz / 312.10 MHz

Test place	Ise EMC Lab. No.4 Semi Anechoic Chamber
Report No.	11398804H
Date	08/17/2016
Temperature/ Humidity	24 deg. C / 54% RH
Engineer	Shinya Watanabe
Mode	Transmitting mode (Tx)

Bandwidth Limit : Fundamental Frequency **312.10** MHz x 0.25% = 780.25

* The above limit was calculated from more stringent nominal frequency.

* Method of KDB 926416 for systems employing non sweeping frequencies was used.

314.35MHz

-20dB Bandwidth [kHz]
39.30

312.10MHz

-20dB Bandwidth [kHz]
39.35

-20dB Bandwidth [kHz]	Bandwidth Limit [kHz]	Result
39.30+39.35=78.65	780.25	Pass

Bandwidth Limit : Fundamental Frequency **314.35** MHz x 0.25% = 785.88 kHz

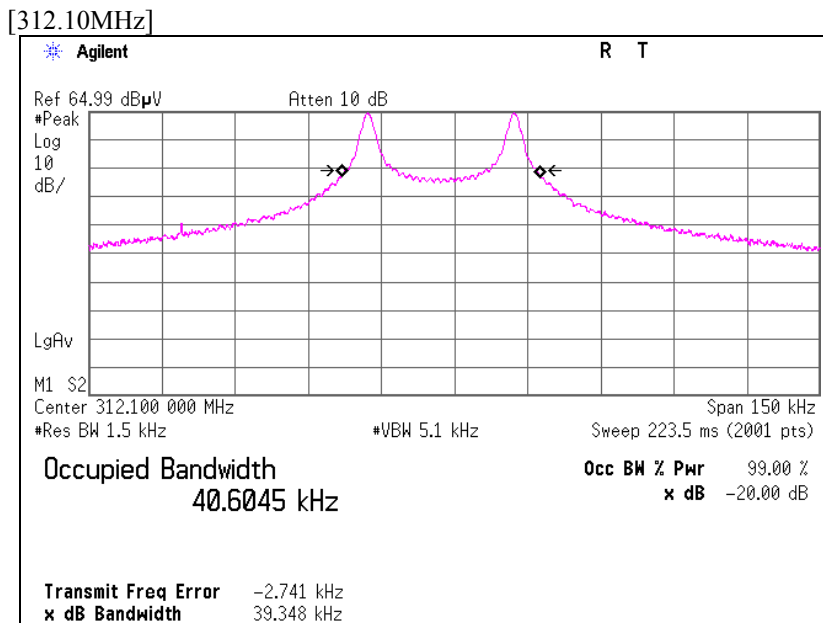
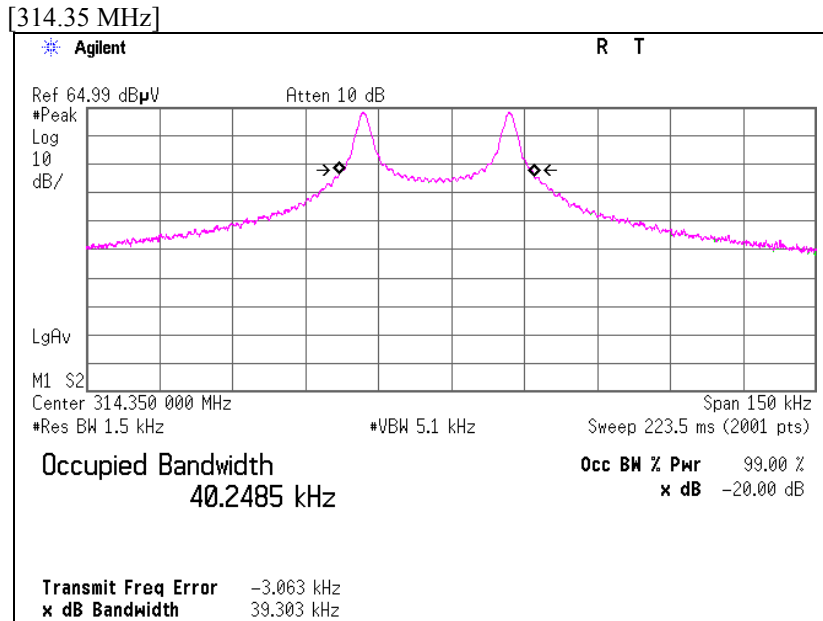
99% Occupied Bandwidth [kHz]	Bandwidth Limit [kHz]	Result
40.25	785.88	Pass

Bandwidth Limit : Fundamental Frequency **312.10** MHz x 0.25% = 780.25 kHz

99% Occupied Bandwidth [kHz]	Bandwidth Limit [kHz]	Result
40.60	780.25	Pass

-20dB and 99% Occupied Bandwidth
314.35 MHz / 312.10 MHz

Test place	Ise EMC Lab. No.4 Semi Anechoic Chamber
Report No.	11398804H
Date	08/17/2016
Temperature/ Humidity	24 deg. C / 54% RH
Engineer	Shinya Watanabe
Mode	Transmitting mode (Tx)



APPENDIX 2: Test Instruments

EMI test equipment

Control No.	Instrument	Manufacturer	Model No	Serial No	Test Item	Calibration Date * Interval(month)
MAEC-04	Semi Anechoic Chamber(NSA)	TDK	Semi Anechoic Chamber 3m	DA-10005	RE	2015/10/02 * 12
MOS-15	Thermo-Hygrometer	Custom	CTH-180	1501	RE	2016/01/21 * 12
MJM-26	Measure	KOMELON	KMC-36	-	RE	-
COTS-MEMI	EMI measurement program	TSJ	TEPTO-DV	-	RE	-
MTR-10	EMI Test Receiver	Rohde & Schwarz	ESR26	101408	RE	2016/01/29 * 12
MBA-05	Biconical Antenna	Schwarzbeck	BBA9106	1302	RE	2015/11/02 * 12
MLA-23	Logperiodic Antenna(200-1000MHz)	Schwarzbeck	VUSLP9111B	911B-192	RE	2016/01/30 * 12
MCC-50	Coaxial Cable	UL Japan	-	-	RE	2016/06/20 * 12
MAT-68	Attenuator	Anritsu	MP721B	6200961025	RE	2015/11/12 * 12
MPA-14	Pre Amplifier	SONOMA INSTRUMENT	310	260833	RE	2016/03/18 * 12
MMM-10	DIGITAL HiTESTER	Hioki	3805	051201148	RE	2016/01/18 * 12
MSA-14	Spectrum Analyzer	Agilent	E4440A	MY48250080	RE	2015/10/07 * 12
MHA-21	Horn Antenna 1-18GHz	Schwarzbeck	BBHA9120D	9120D-557	RE	2015/08/10 * 12
MCC-141	Microwave Cable	Junkosha	MWX221	1305S002R(1m) / 1405S146(5m)	RE	2016/06/21 * 12
MPA-12	MicroWave System Amplifier	Agilent	83017A	00650	RE	2015/10/01 * 12
MLPA-07	Loop Antenna	UL Japan	-	-	RE	Pre Check

The expiration date of the calibration is the end of the expired month.

All equipment is calibrated with valid calibrations. Each measurement data is traceable to the national or international standards.

As for some calibrations performed after the tested dates, those test equipment have been controlled by means of an unbroken chains of calibrations.

Test Item:

RE: Radiated emission, 99% Occupied Bandwidth, -20dB bandwidth, and Automatically deactivate tests

UL Japan, Inc.

Ise EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8999

Facsimile : +81 596 24 8124